CD74FCT844A BICMOS 9-BIT BUS-INTERFACE D-TYPE LATCH WITH 3-STATE OUTPUTS

SCBS728 - JULY 2000

 BiCMOS Technology With Low Quiescent Power 	EN PACKAGE (TOP VIEW)					
Buffered Inputs						
Inverted Outputs	1D 2 23 1Q					
 Input/Output Isolation From V_{CC} 	2D 🛛 3 22 🗍 2Q					
Controlled Output Edge Rates	3D [] 4 21 [] 3Q					
 48-mA Output Sink Current 	$4D$ 5 20 $4\overline{Q}$					
•	5D [] 6 19 [] 5Q					
 Output Voltage Swing Limited to 3.7 V 	6D U 7 18 U 6 Q					
 SCR Latch-Up-Resistant BiCMOS Process 	7D 🛛 8 17 🗍 7Q					
and Circuit Design	8D 🛛 9 16 🗋 8Q					
 Packaged in Standard Plastic DIP 	9D 🛛 10 15 🗍 9Q					
5	CLR [11 14] PRE					
description	GND [12 13] LE					

The CD74FCT844A is a 9-bit, D-type latch with

3-state outputs, designed specifically for driving

highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

The CD74FCT844A outputs are transparent to the inputs when the latch-enable (LE) input is high. When LE goes low, the data is latched. The output-enable (\overline{OE}) input controls the 3-state outputs. When \overline{OE} is high, the outputs are in the high-impedance state. The latch operation is independent of the state of \overline{OE} . This device, having preset (PRE) and clear (CLR), is ideal for parity-bus interfacing. When \overline{PRE} is low, the outputs are high if \overline{OE} is low. PRE overrides \overline{CLR} . When \overline{CLR} is low, the outputs are low if \overline{OE} is low. When \overline{CLR} is high, data can be entered into the latch.

OE can be used to place the nine outputs in either a normal logic state (high or low logic levels) or the high-impedance state. The outputs also are in the high-impedance state during power-up and power-down conditions. The outputs remain in the high-impedance state while the device is powered down. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

The CD74FCT844A is characterized for operation from 0°C to 70°C.



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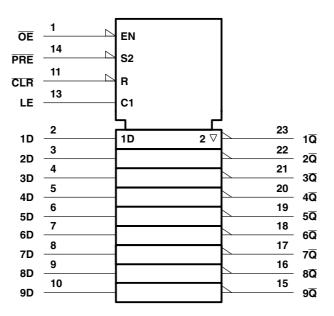


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FUNCTION TABLE (each latch)										
	INPUTS									
PRE	CLR	ŌE	LE	D	Q					
L	Х	L	Х	Х	Н					
н	L	L	х	Х	L					
н	н	L	н	L	н					
н	н	L	н	н	L					
н	н	L	L	Х	Q ₀					
Х	Х	Н	Х	Х	Q ₀ Z					

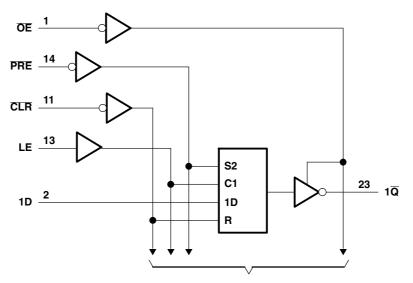
logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



To Eight Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

DC supply voltage range, V _{CC}	–0.5 V to 6 V
DC input clamp current, $I_{ K}$ ($V_{ }$ < -0.5 V)	–20 mA
DC output clamp current, I _{OK} (V _O < -0.5 V)	–50 mA
DC output sink current per output pin, I _{OL}	70 mA
DC output source current per output pin, I _{OH}	–30 mA
Continuous current through V _{CC} , (I _{CC})	237 mA
Continuous current through GND	453 mA
Package thermal impedance, θ_{JA} (see Note 1)	67°C/W
Storage temperature range, T _{stg}	. −65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
V _{CC}	Supply voltage	4.75	5.25	V
V _{IH}	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	V _{CC}	V
Vo	Output voltage	0	V _{CC}	V
I _{OH}	High-level output current		-15	mA
I _{OL}	Low-level output current		48	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	ns/V
T _A	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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electrical characteristics over recommended operating temperature range (unless otherwise noted)

DADAMETED		N N	T _A = 2	25°C	MIN	мах	UNIT	
PARAMETER	TEST CONDIT	v _{cc}	MIN	MAX				
V _{IK}	I _I = -18 mA		4.75 V		-1.2		-1.2	V
V _{OH}	I _{OH} = -15 mA		4.75 V	2.4		2.4		V
V _{OL}	I _{OL} = 48 mA		4.75 V		0.55		0.55	V
l _l	$V_I = V_{CC}$ or GND		5.25 V		±0.1		±1	μA
I _{OZ}	$V_{O} = V_{CC}$ or GND		5.25 V		±0.5		±10	μA
I _{OS} †	$V_I = V_{CC}$ or GND,	$V_{O} = 0$	5.25 V	-75		-75		mA
I _{CC}	$V_I = V_{CC}$ or GND,	I _O = 0	5.25 V		8		80	μA
ΔI_{CC}^{\ddagger}	One input at 3.4 V, Other inputs at V_{CC} or GND		5.25 V		1.6		1.6	mA
Ci	V _I = V _{CC} or GND				10		10	pF
Co	$V_{O} = V_{CC}$ or GND				15		15	pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.

[‡] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

timing requirements over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT
		CLR low	8		
t _w	Pulse duration	PRE low	8		ns
		LE low	4		
	Setup time	Data before LE \downarrow	2.5		
t _{su}		PRE inactive	2.5		ns
		CLR inactive	2.5		
t _h	Hold time	Data before LE \downarrow	2.5		ns
t _{rec}	Recovery time	PRE, CLR	14		ns

switching characteristics over recommended operating temperature conditions (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	T _A = 25°C			
PARAMETER	(INPUT)	(OUTPUT)	ТҮР	MIN	MAX	UNIT
	D	~	7.5	1.5	10	
^t pd	LE	Q	9	1.5	12	ns
t _{PLH}	PRE		9	1.5	12	
t _{PHL}	CLR	Q	9.8	1.5	13	ns
t _{en}	ŌĒ	Q	10.5	1.5	14	ns
t _{dis}	ŌĒ	Q	6	1.5	8	ns



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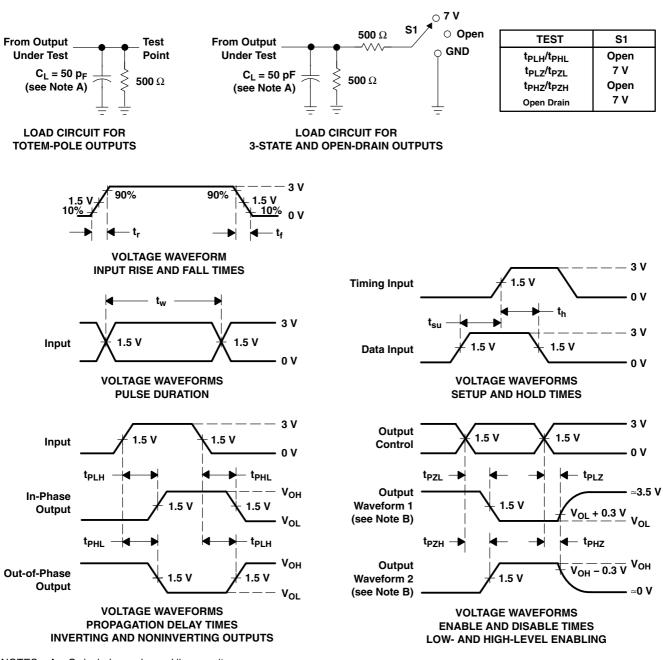
noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C

	PARAMETER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		1		V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		0.5		V
V _{IH(D)}	High-level dynamic input voltage	2			V
V _{IL(D)}	Low-level dynamic input voltage			0.8	V



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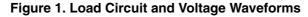
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PARAMETER MEASUREMENT INFORMATION

NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r and t_f = 2.5 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. t_{PL7} and t_{PH7} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en}.
- G. t_{PHL} and t_{PLH} are the same as t_{pd}.







11-Apr-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
CD74FCT844AEN	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	0 to 70		

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

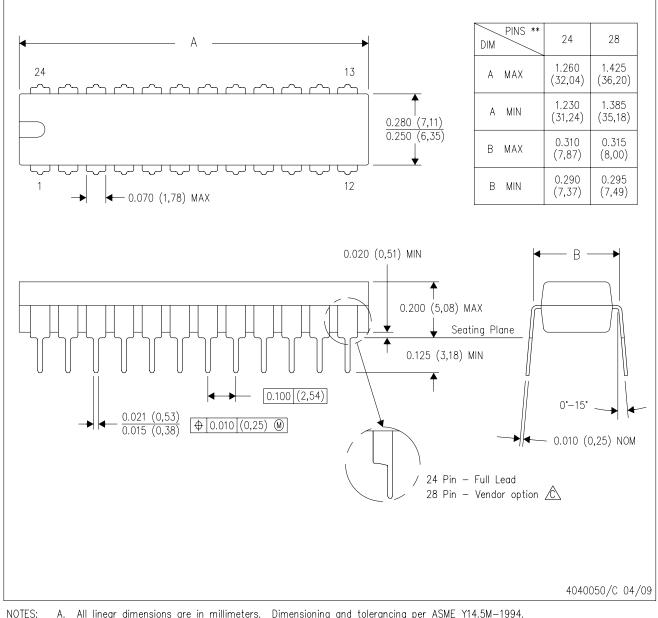
(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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NT (R-PDIP-T**) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



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